

5/7/2020

Functional Testing Specification

Parts & Repair Services Louisville, KY

LOU-GED-IS200ICBD

Test Procedure for a

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Page 2 of 5

REV. A

1. SCOPE

1.1 This is a functional testing procedure for an IS200ICBD Card.

2. STANDARDS OF QUALITY

2.1 Refer to the current revision of the IPC-A-610 standard for workmanship standards.

3. APPLICABLE DOCUMENTS

- **3.1** The following document(s) shall form part of this specification to the extent specified herein. Unless otherwise indicated, the latest issue shall apply.
 - **3.1.1** Check board's electronic folder for more information

4. ENGINEERING REQUIREMENTS

- 4.1 Equipment Cleaning
 - **4.1.1** Equipment should be clean and free of debris prior to applying power unless performing an initial check. Refer to site specific SRA's for cleaning guidelines.
- **4.2** Equipment Inspection
 - **4.2.1** Equipment should be visually inspected for any defects prior to applying power. This inspection should include the following as a minimum:
 - 4.2.1.1 Wires broken, cracked, or loosely connected
 - 4.2.1.2 Terminal strips / connectors broken or cracked
 - 4.2.1.3 Components visually damaged
 - 4.2.1.4 Capacitors bloated or leaking
 - 4.2.1.5 Solder joints damaged or cold
 - 4.2.1.6 Circuit board burned or de-laminated
 - 4.2.1.7 Printed wire runs / Traces burned or damaged

5. **EQUIPMENT REQUIRED**

5.1 The following equipment is required to perform the process requirements. Equipment may be substituted provided that all accuracy's and test ratios are equivalent or better.

Qty	Reference #	Description
1		Fluke 87 DMM (or Equivalent)
1		Tenma Power Supply
1		10K Ohm Resistor

6. Modifications/Upgrades

6.1 IS200ICBDH1B replaces the IS200ICBDH1A, H1As were prone to bad messages and network crashes.



7. Testing Process

7.1 Setup

7.1.1 Connect power to the board (see Table 1-1 below).

Table 1-1

Voltage	То
+24 VDC	2PL-9
-24 VDC	2PL-8
+5 VDC	2PL-5 or 6
GND	2PL-4 or 7

7.2 Testing Procedure

7.2.1 Apply power to the card. Power should be applied during the following tests.

7.2.2 Isolated Voltages

7.2.2.1 Check for IP12 and IP24 voltages using Table 1-2.

Table 1-2

Voltage	J14-A, B, or C	J15-A, B, or C
+12 VDC	Pin 13	Pin 13
GND	Pin 14	Pin 14
+24 VDC	Pin 16	Pin 16
GND	Pin 15	Pin 15

7.2.3 IPOK Circuit

- **7.2.3.1** Apply 5 VDC to J15-B8 thru a 10K ohm pullup resistor.
- 7.2.3.2 Measure voltage at J15-B8 (use 2PL-4 or 7 for GND), voltage will be low.
- 7.2.3.3 Remove -24 VDC and J15-B8 will go high.
- 7.2.3.4 Reapply -24 VDC to 2PL-8.

7.2.4 Reset Circuit

- **7.2.4.1** Connect GND to 2PL-1, this must be low for circuit to work.
- 7.2.4.2 Check voltage at J13-A1 and 1PL-31, they will be high.
- 7.2.4.3 Push reset button SW1, J13-A1 and 1PL-31 will go low.
- 7.2.4.4 Remove GND from 2PL-1.

7.2.5 Inverting Buffers



REV. A

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- **7.2.5.1** Use 5 VDC thru a 10K ohm pullup resistor to toggle the input of U9 (1PL-38) while checking the output (J14-B24) to change from high to low.
- **7.2.5.2** Use Table 1-3 and apply 5 VDC to the inputs of QN1.
- **7.2.5.3** Toggle the inputs and check the outputs using 5 VDC thru a 10K ohm pullup resistor.

Table 1-3

IC	Input	Output
QN1-1	J14-B26	IOPL-19
QN1-2	J14-B27	IOPL-20
QN1-3	J14-C24	IOPL-21
QN1-4	J14-C25	IOPL-22
QN1-5	J14-C26	IOPL-23
QN1-6	J14-C27	IOPL-24
QN1-7	J14-C32	IOPL-25

7.2.5.4 Use Table 1-4 and apply a low (GND) to the inputs of each IC while checking the outputs to change from high to low. NOTE: (U10/U15-FHO0 - U10/U15-FHO3 will toggle the same as the input, due to them going thru two invertors)

Table 1-4

IC	Input	Output
U8-FIN0	1PL-8	J13-B26
U7-FIN1	1PL-9	J13-C18
U7-FIN2	1PL-10	J13-C30
U7-FIN4	1PL-11	J13-B31
U7-FIN5	1PL-12	J13-C24
U7-FIN6	1PL-13	J13-B20
U7-FIN7	1PL-39	J13-C10
U8-FIN8	1PL-40	J13-C27
U8-FT2R	1PL-28	J13-B23
U8-FHI0	1PL-29	J13-B29
U10/U15-FHO0	J13-B28	1PL-16
U10/U15-FHO1	J13-B24	1PL-17

Page 5 of 5

Table 1-4 (cont.)

Input	Output
J13-C20	1PL-18
J13-C16	1PL-19
J13-C22	1PL-35
J13-C26	1PL-36
J13-B14	1PL-14
J13-C32	1PL-20
J13-C28	1PL-21
J13-B8	1PL-22
J13-B13	1PL-23
J13-B15	1PL-24
J13-B17	1PL-25
J13-B18	1PL-26
J13-B22	1PL-27
J13-C14	1PL-32
J13-C15	1PL-33
IOPL-18	J14-A6
IOPL-2	J14-A7
IOPL-3	J14-A8
IOPL-4	J14-A9
IOPL-5	J14-A10
IOPL-6	J14-A11
IOPL-7	J14-B23
IOPL-8	J14-B25
	J13-C20 J13-C16 J13-C22 J13-C26 J13-B14 J13-C32 J13-C28 J13-B13 J13-B15 J13-B17 J13-B18 J13-B22 J13-C14 J13-C15 IOPL-18 IOPL-2 IOPL-3 IOPL-4 IOPL-5 IOPL-6 IOPL-7

7.3 Post Testing Burn-in

Required <u>X</u> Yes ___ No

7.3.1 Place board in the DC2000 Drive and run for one hour with errors.

7.4 ***TEST COMPLETE ***

8. Notes

8.1 None at this time?

9. Attachments

9.1 None at this time?